Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	er
09/985,851	NISHIWAKI ET AL.	
Examiner	Art Unit	
Ronald Laneau	3627	

	SEARCHED				
Class	Subclass	Date	Examiner		
705	26,27	5/24/2006	RL		
701	200,201	5/24/2006	RL		
701	202	5/24/2006	RL		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
705	026	5/24/2006	RL	
			-	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EIC Template Search	5/24/2006	RL		